

Control Systems Dept. of Electrical Engineering

Detection of Bifurcation in flow patterns in Glass Manufacturing Process

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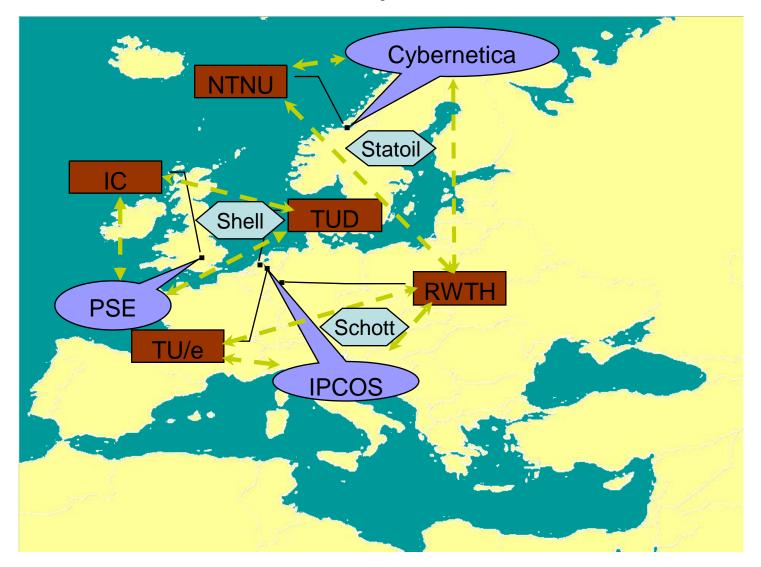


Outline

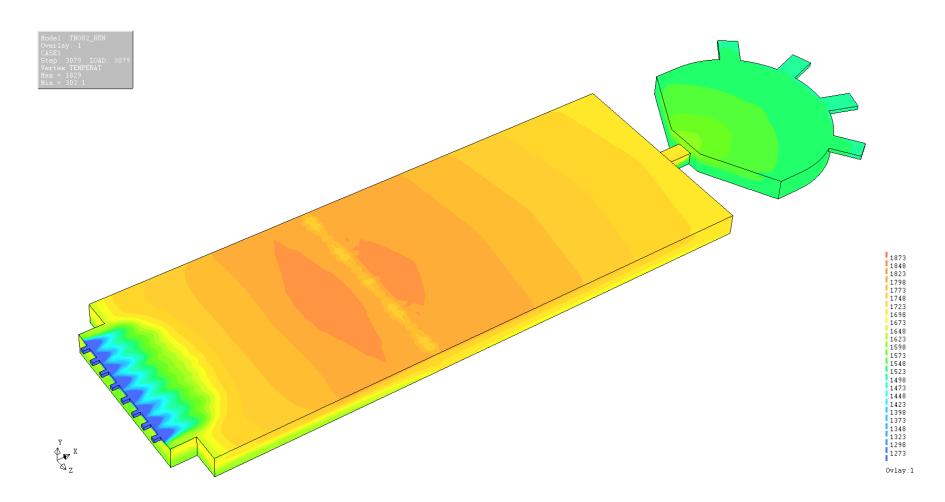
- Motivation Glass + Corrosion
- Corrosion influence
- Problem statement
- Proposed solution- Detection mechanism
- Strategy towards solution of the problem
- Identification results
- Conclusion
- Benchmark problem repository

PROMATCH

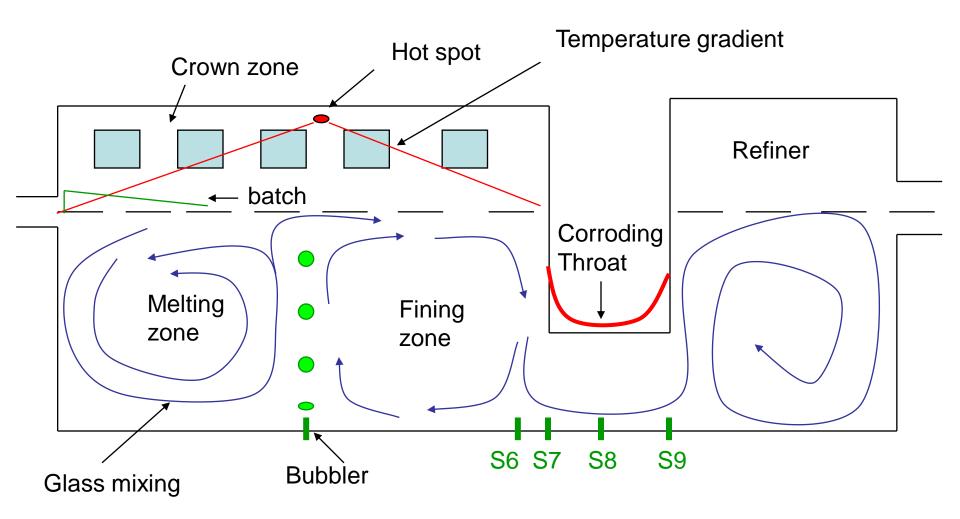
PROmoting and structuring Multidisciplinary Academic-industrial collaboration in research and Training trough SME teCHnology developers



Application: CRT Glass Manufacturing Tank



Motivation: Glass + Corrosion



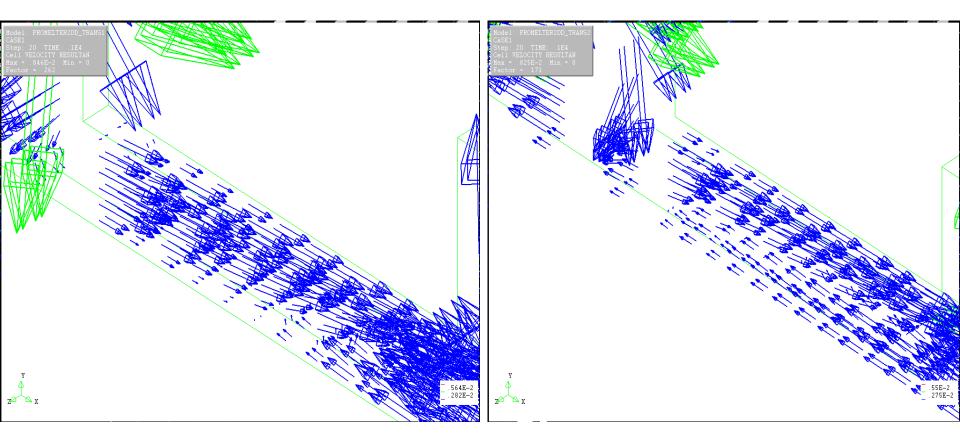
2D glass tank model Specifications

- Dimensions (m): 37.2 x 1 x 0.1
- 2 grid cells in z-direction, total ~ 6000 cells
- Capacity: 3.5 tons/day
- One bubbler
- Steep temperature profile in z-direction to get mixing in z-direction
- Almost complete model geometry parameterized
- Inclusion of basic models flow, energy, batch, bubbling
- Model constants, parameter values, solver schemes, convergence criterion similar to 3D model

Outline

- Problem Description: Motivation
- Corrosion Influence

Occurrence of back-flow



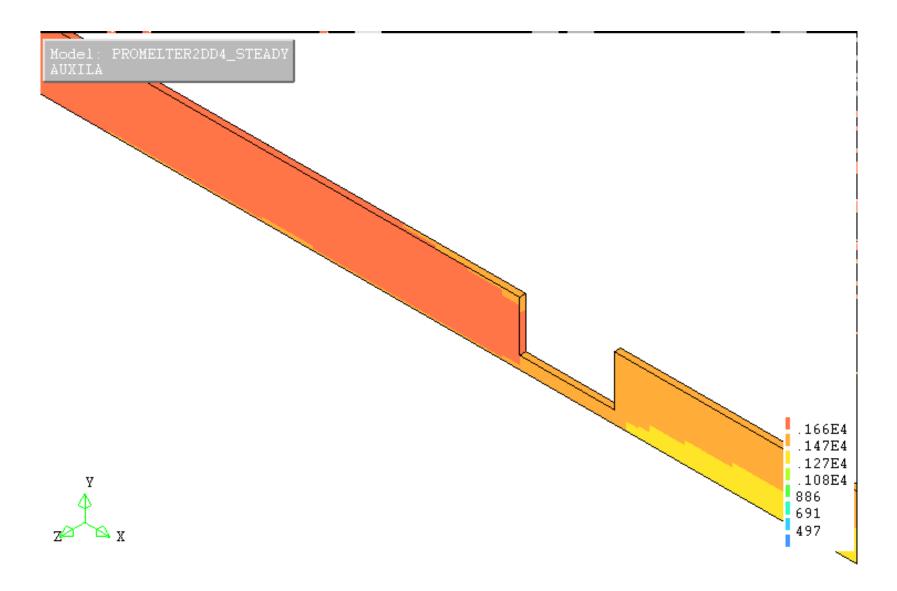
Below critical value (h⁻)

Above critical value (h+)

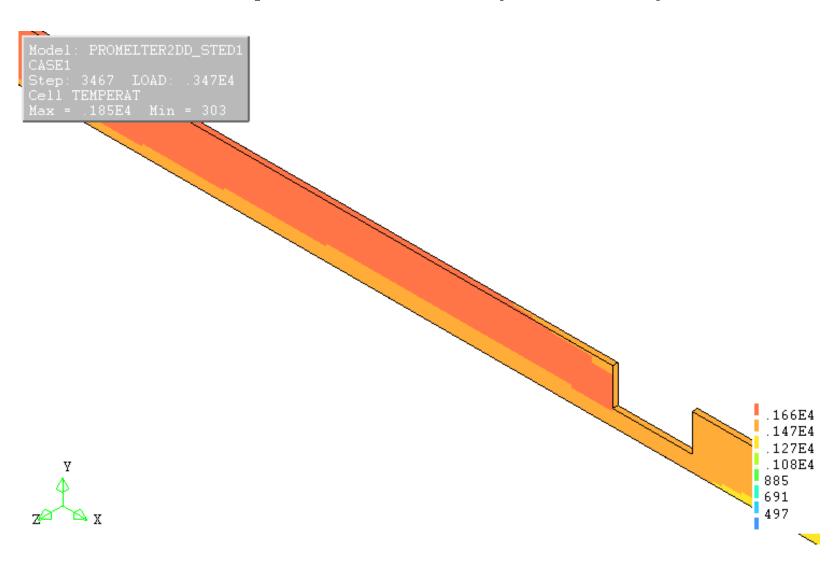
Bifurcation parameter window

 $h^- < h^* < h^+ = 0.2m < h^* < 0.3 m$

Temperature (h=0.2)



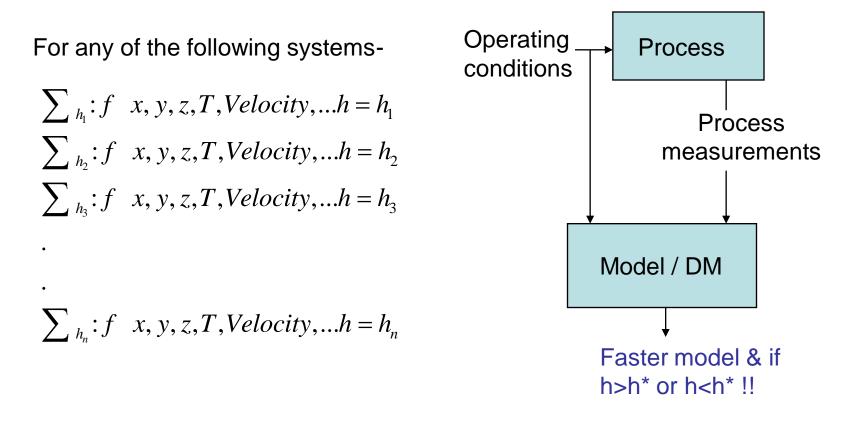
Temperature (h=0.3)



Outline

- Motivation
- GTM-X experimental results
- Problem statement

Problem statement



Q: Given few measurements and some system knowledge, can one detect the bifurcation parameter value?

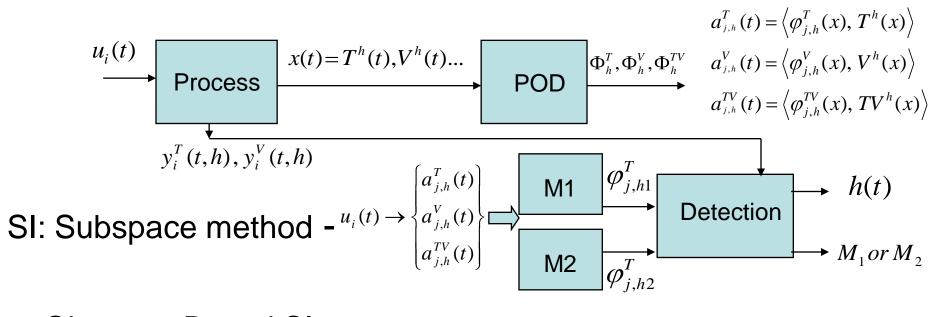
A: POD + subspace identification + Dynamic Detection Mechanism

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Strategy towards solution of the problem

• POD based (for $h_1=0.2, h_2=0.3$)



• Observer Based SI $u_i(t)$ $u_i(t)$ $y_i^T(t,h)$ $u_i(t,h)$ $u_i(t)$ $u_i(t)$ $u_i(t)$ $u_i(t)$ $u_i(t)$ $u_i(t,h)$ $u_i(t,h)$ u

Proper Orthogonal Decomposition (POD)

• POD Basis Problem

Given data $w_1, ..., w_M \in W$, find orthonormal basis $\phi_k, k = 1, 2, ...$ of W such that the error

$$J(\varphi_1, \dots, \varphi_r) = \sum_{j=1}^M \|w_j - \sum_{k=1}^r \langle w_j, \varphi_k \rangle \varphi_k \|^2$$

Is minimal for all truncation levels r

Basis are-

- 1. Data dependent
- 2. Needs inner product $\langle f, g \rangle$ on W
- 3. Basis needs to be orthonormal

Solution to POD basis problem

- An orthonormal basis φ_k is POD basis if and only if $WW^T \varphi_k = \lambda_k \varphi_k$
- Problem of finding POD basis is equivalent to eigenvalue problem
- Need to compute , $W = U\Sigma V^T$ i.e. Singular Value Decomposition
- U,V : unitary matrices, ∑ singular values arranged in decreasing order, columns of U form POD basis
- Original DPS model is projected on POD basis, φ_k Galerkin projection when U=V

POD continued...

• PDE or distributed systems

• Model:

$$\frac{\partial w}{\partial t} = F\left(w, \frac{\partial w}{\partial z}, \dots, \frac{\partial^n w}{\partial z^n}, u\right)$$

- Variable projection
 W(x,t) ≈ U W_r(x,t)
- Vector field projection

$$imV \perp \left(\frac{\partial w}{\partial t} - F\left(\frac{\partial w}{\partial x}, \dots, u\right)\right)$$

• Galerkin Projection U=V

- Reduced order model
- Variable and vector field projections are combined
- Inner product on Hilbert space yields reduced models

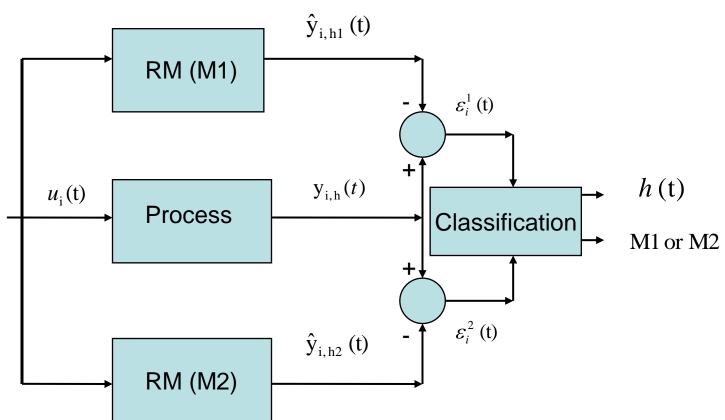
$$\left\langle v, \frac{\partial w_r}{\partial t} \right\rangle = \left\langle v, F\left(w_r, \frac{\partial w_r}{\partial x}, \dots, \frac{\partial^n w_r}{\partial x^n}u\right) \right\rangle$$
$$w_r = \left\langle u, w \right\rangle$$
$$y(x, t) = g(w_{r, u})$$

• Where $u \in imU, v \in imV \& \langle .,. \rangle$ is inner product

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Bifurcation Detection



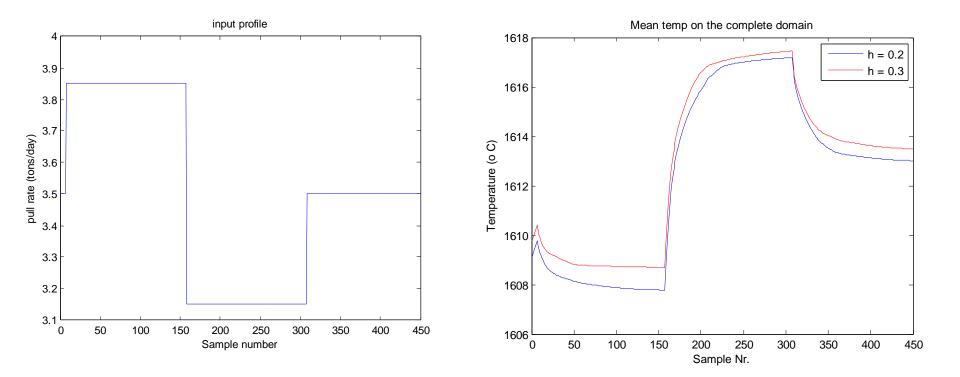
Assumption : Process bifurcation parameter is above or below critical value.

Disadvantage: For small difference and substantial noise presence can lead to wrong result.

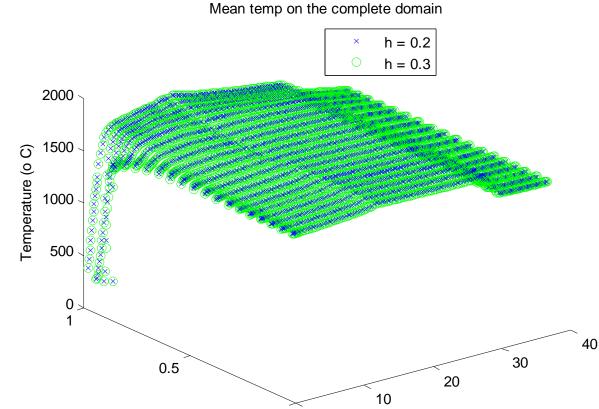
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Average Temperature Profile in the tank – mean on domain, actual data



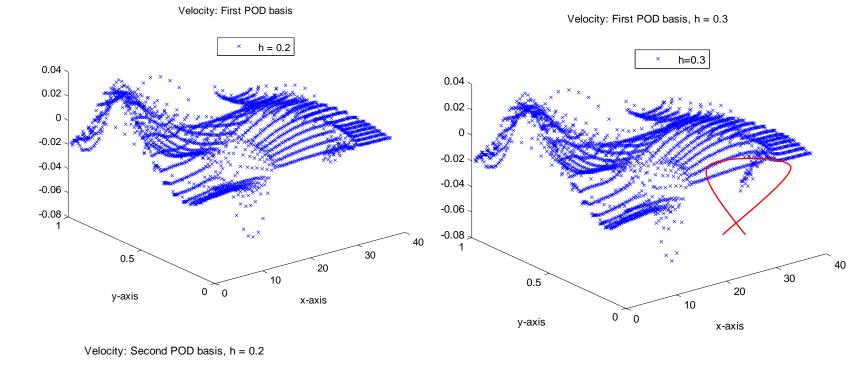
Average Temperature Profile in the tank – mean on time

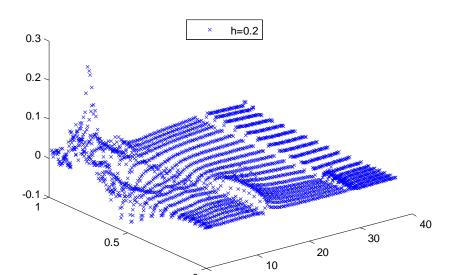


Y-Axis

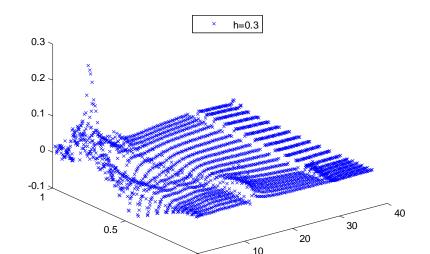
0 0 X-Axis

First four POD basis functions (V), h=0.2, 0.3

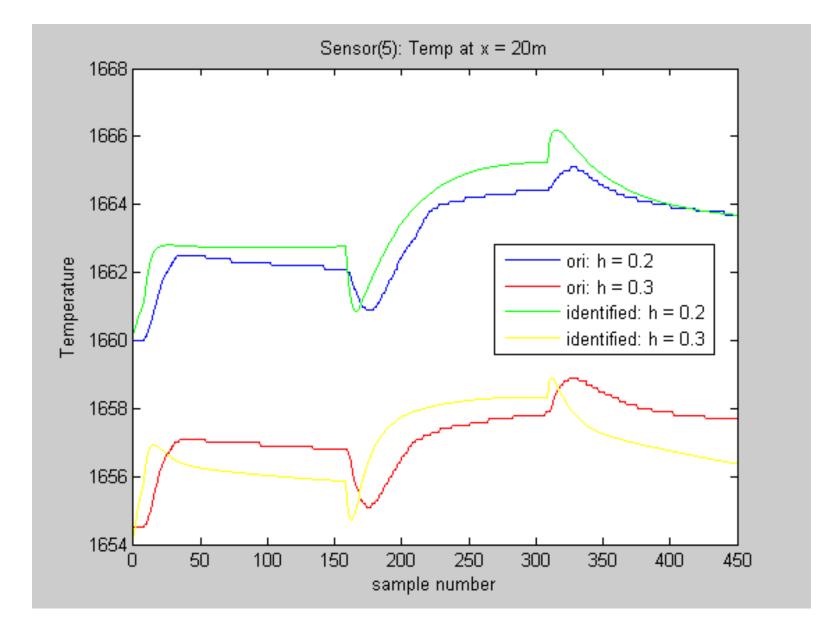




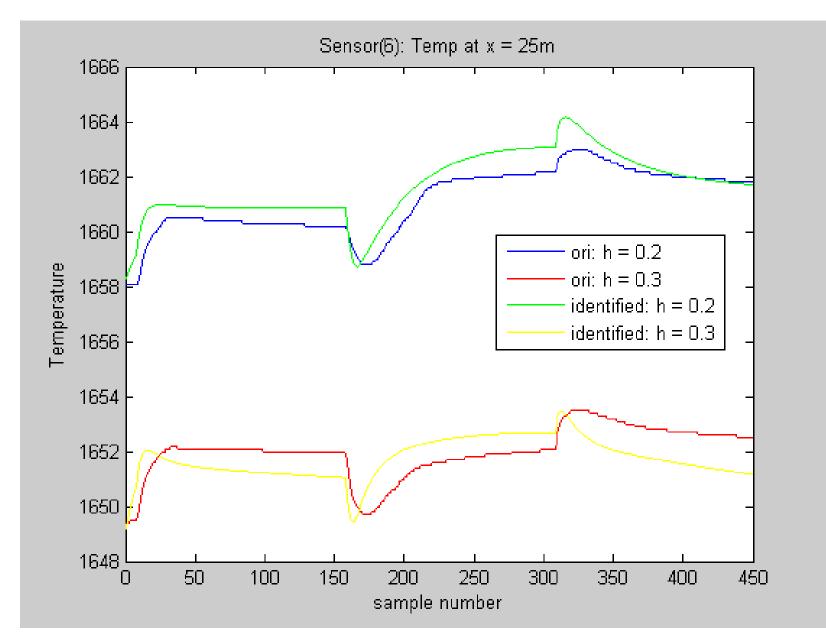
Velocity: Second POD basis, h = 0.3



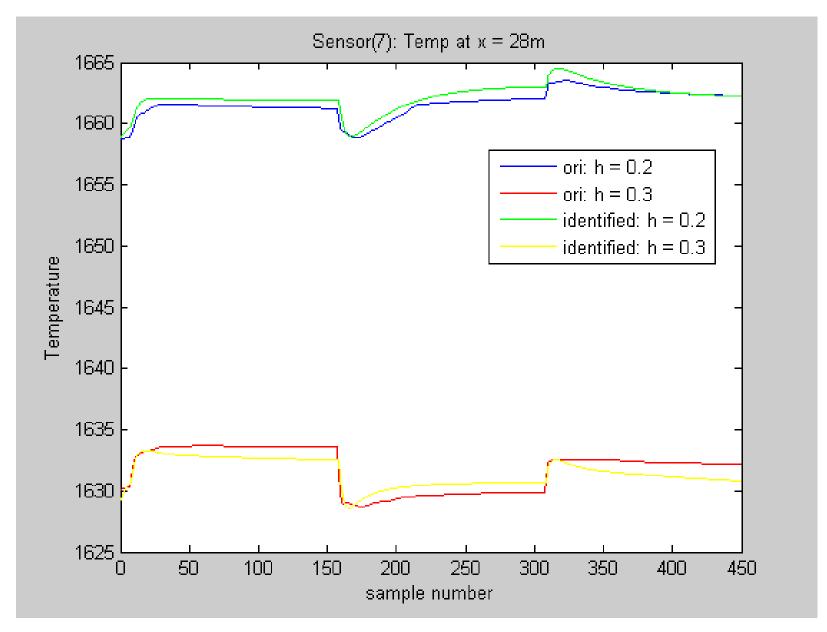
Temp, x=20m (7m left side of throat)



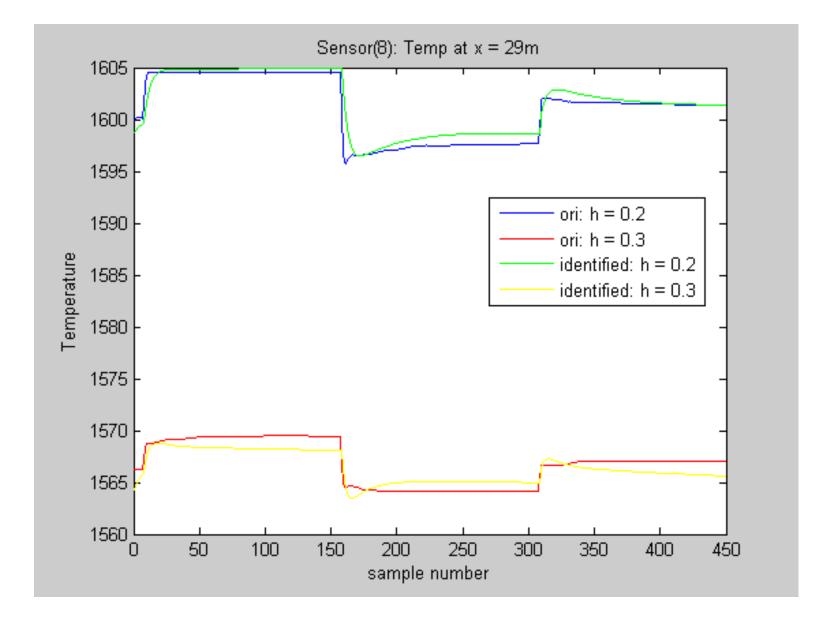
Temp, x=25m (3m left side of throat)



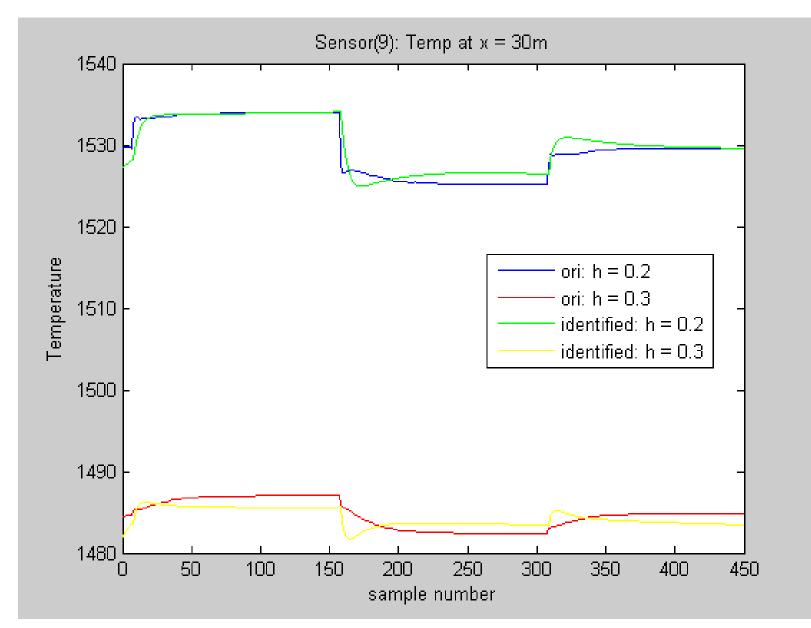
Temp, x=28m (start of throat)



Temp, x=29m (middle of throat)



Temp, x=30m (end of throat)



Conclusions and future work

- Detection mechanism based on reduced model identification (subspace) can probably be used for detecting corrosion occurring in the glass manufacturing process.
- Effectiveness of this approach need to be checked for smaller corrosion effect.
- Closed loop performance (to stop back-flow)
- Observer based detection mechanism
- Distinguishability based on POD basis

References

• P. Astrid, PhD report 2004

• L. Huisman, PhD report 2005

• Wattamwar S., Weiland S., CCA 2008 contribution

PROMATCH Symposium

- On November 4 Frankfurt, DECHEMA
- Will have presentation from invited speakers and PROMATCH partners
- Benchmark problem repository + methodology documentation, will be distributed (CD)

Benchmark Repository – Process Industry

- Systems Lumped, Distributed, Mixed
- Applications Glass, Distillation, CSTR
- Methodologies POD+SID, Grey-box model, Compartmental model, Hammerstein model
- Platforms Matlab, GTMx, Gproms, etc.
- Level easy to Complex
- Problems software licenses!!

PROPOSAL to this group

• Share the presentation slides !!

THANK YOU!!